

Search Notes

Application/Control No.

09/818,567

Examiner

Ellen C. Tran

Applicant(s)/Patent under
Reexamination

FURUYA ET AL.

Art Unit

2134

SEARCHED

Class	Subclass	Date	Examiner
380	259	3/16/2006	ECT
380	210	3/16/2006	ECT
713	193	3/16/2006	ECT

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
Interference Search		3/16/2006	ECT

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
USPTO, USPG, EPO, JPO, DERWENT, IBM TECH DES, NPL	3/16/2006	ECT